

8N65

Power MOSFET

8A, 650V N-CHANNEL
POWER MOSFET

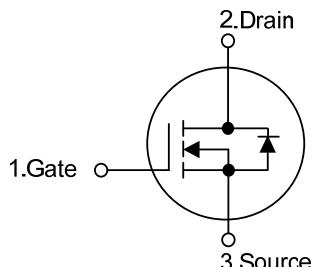
■ DESCRIPTION

The UTC **8N65** is a high voltage and high current power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications at power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

- * $R_{DS(ON)} < 1.4\Omega @ V_{GS} = 10\text{ V}$
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

■ SYMBOL



■ ORDERING INFORMATION

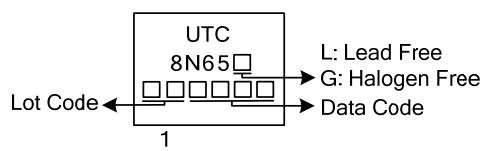
Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
8N65L-TA3-T	8N65G-TA3-T	TO-220	G	D	S	Tube
8N65L-TF3-T	8N65G-TF3-T	TO-220F	G	D	S	Tube
8N65L-TF1-T	8N65G-TF1-T	TO-220F1	G	D	S	Tube
8N65L-TF3T-T	8N65G-TF3T-T	TO-220F3	G	D	S	Tube
8N65L-T2Q-T	8N65G-T2Q-T	TO-262	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

 (1) Packing Type (2) Package Type (3) Lead Free	(1) T: Tube (2) TA3: TO-220 ,TF3: TO-220F ,TF1: TO-220F1 , TF3T: TO-220F3 ,T2Q: TO-262 (3) L: Lead Free, G: Halogen Free
---	---

■ MARKING INFORMATION

PACKAGE	MARKING
TO-220	
TO-220F	
TO-220F1	
TO-220F3	
TO-262	



■ ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage	V_{DSS}	650	V	
Gate-Source Voltage	V_{GSS}	± 30	V	
Avalanche Current (Note 2)	I_{AR}	8	A	
Drain Current	Continuous	I_D	8	A
	Pulsed (Note 2)	I_{DM}	32	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	230	mJ
	Repetitive (Note 2)	E_{AR}	14.7	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	4.5	V/ns	
Power Dissipation	TO-220/TO-262	P_D	147	W
	TO-220F/TO-220F1		48	W
	TO-220F3			
Junction Temperature	T_J	+150	$^\circ\text{C}$	
Operating Temperature	T_{OPR}	-55 ~ +150	$^\circ\text{C}$	
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ\text{C}$	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by T_J

3. L=7.1mH, $I_{AS}=8\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

4. $I_{SD} \leq 8\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J=25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	62.5	$^\circ\text{C/W}$	
Junction to Case	TO-220/TO-262	θ_{JC}	0.85	$^\circ\text{C/W}$
	TO-220F/TO-220F1		2.6	$^\circ\text{C/W}$
	TO-220F3			

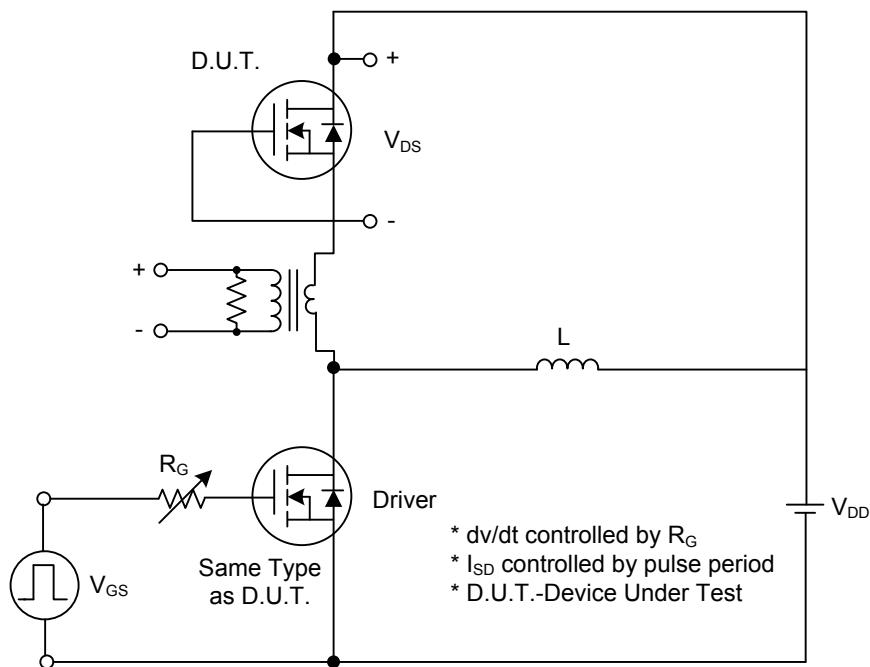
■ ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250 \mu\text{A}$	650			V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}} = 650 \text{ V}, V_{\text{GS}} = 0 \text{ V}$		10		μA
Gate-Source Leakage Current	Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$		100		nA
	Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$		-100		nA
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	$I_{\text{D}} = 250 \mu\text{A}$, Referenced to 25°C		0.7		$\text{V}/^\circ\text{C}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250 \mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}} = 10 \text{ V}, I_{\text{D}} = 4 \text{ A}$		1.2	1.4	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1 \text{ MHz}$		1145	1255	pF
Output Capacitance	C_{OSS}			118	135	pF
Reverse Transfer Capacitance	C_{RSS}			19	25	pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	$t_{\text{D(ON)}}$	$V_{\text{DD}} = 325 \text{ V}, I_{\text{D}} = 8 \text{ A}, R_{\text{G}} = 25 \Omega$ (Note 1, 2)		84	100	ns
Turn-On Rise Time	t_{R}			100	130	ns
Turn-Off Delay Time	$t_{\text{D(OFF)}}$			275	320	ns
Turn-Off Fall Time	t_{F}			64.5	140	ns
Total Gate Charge	Q_{G}	$V_{\text{DS}} = 520 \text{ V}, I_{\text{D}} = 8 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 1, 2)		115	130	nC
Gate-Source Charge	Q_{GS}			12		nC
Gate-Drain Charge	Q_{GD}			40		nC
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{\text{GS}} = 0 \text{ V}, I_{\text{S}} = 8 \text{ A}$			1.4	V
Maximum Continuous Drain-Source Diode Forward Current	I_{S}				8	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				32	A
Reverse Recovery Time	t_{RR}	$V_{\text{GS}} = 0 \text{ V}, I_{\text{S}} = 8 \text{ A}, dI_{\text{F}}/dt = 100 \text{ A}/\mu\text{s}$ (Note 2)		365		ns
Reverse Recovery Charge	Q_{RR}			3.4		μC

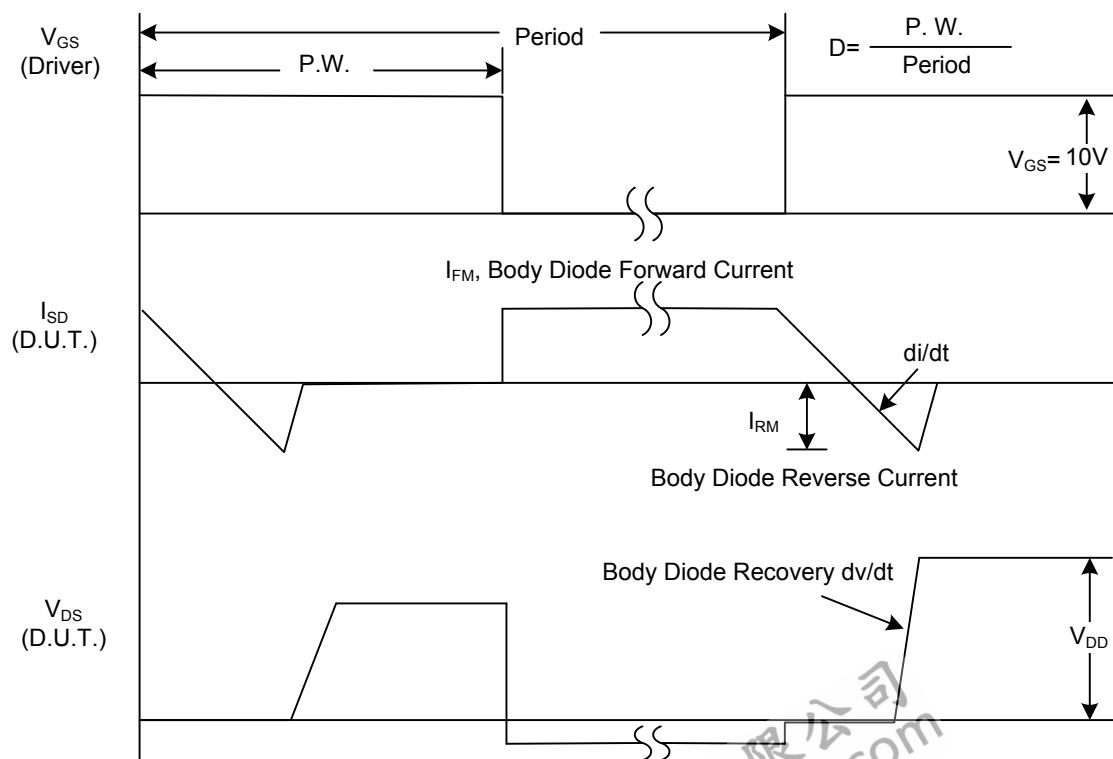
Notes: 1. Pulse Test: Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$

2. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

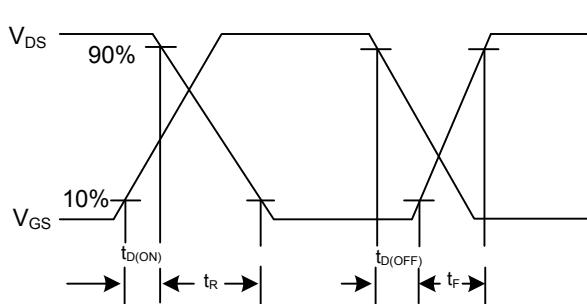
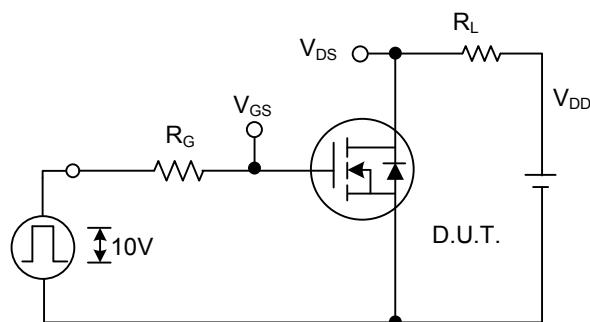


Peak Diode Recovery dv/dt Test Circuit



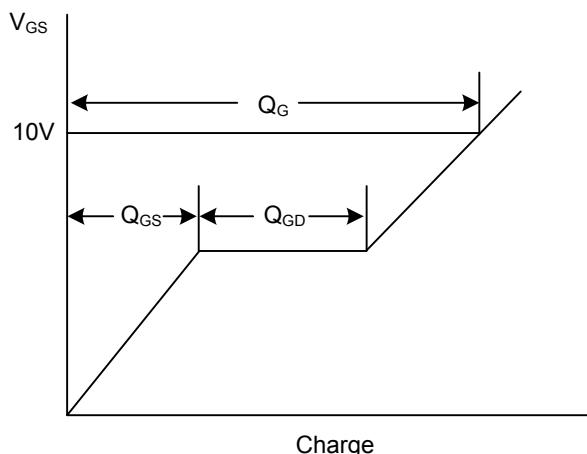
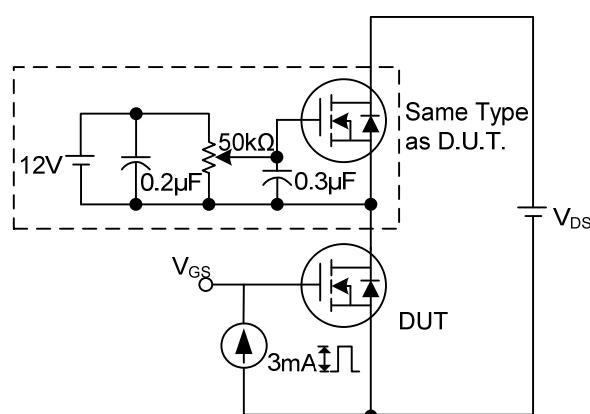
Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)



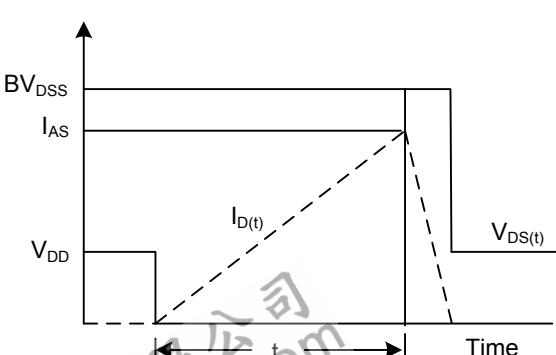
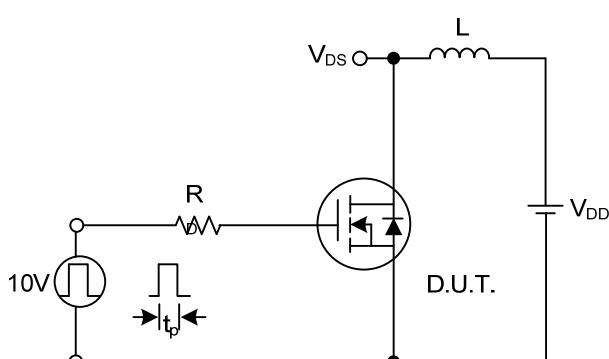
Switching Test Circuit

Switching Waveforms



Gate Charge Test Circuit

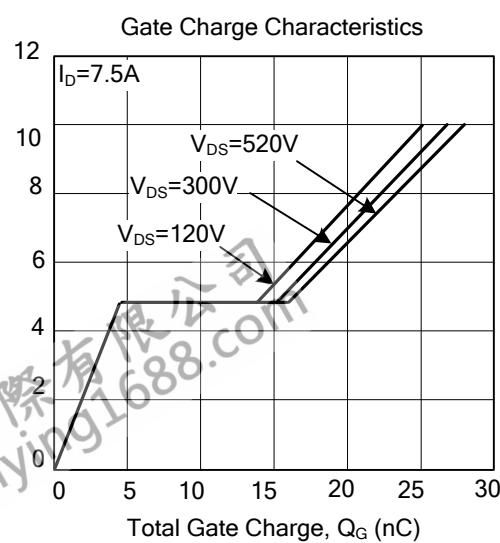
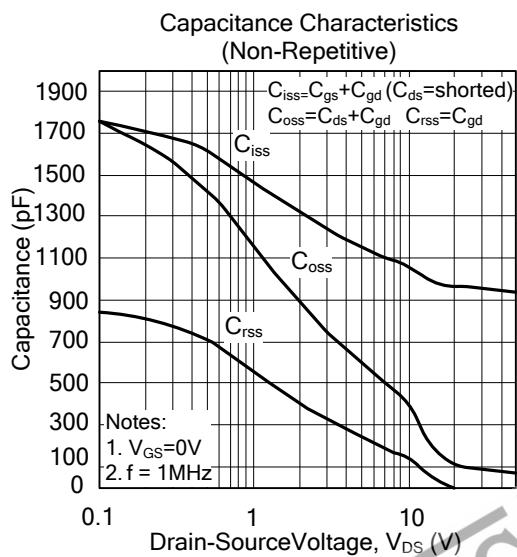
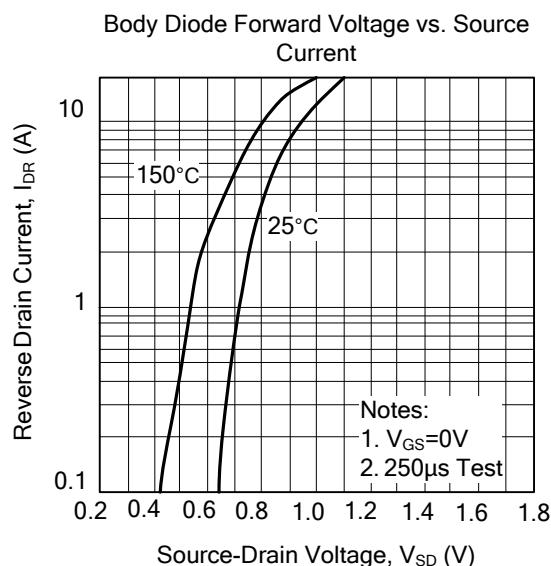
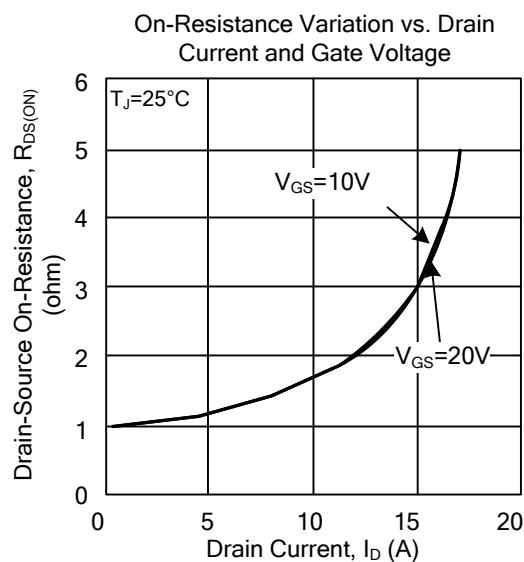
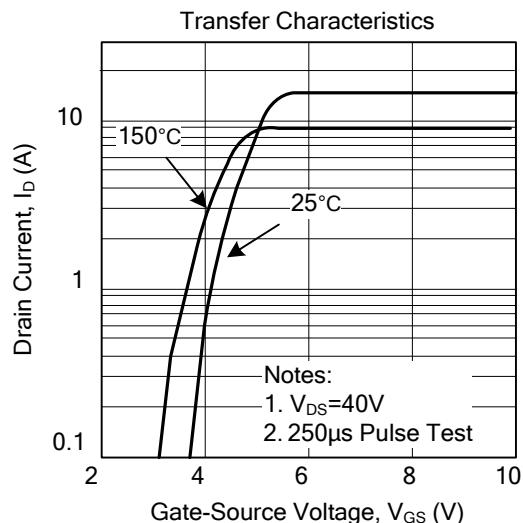
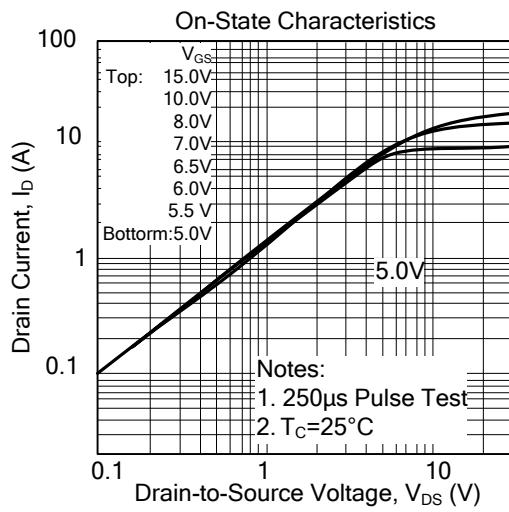
Gate Charge Waveform



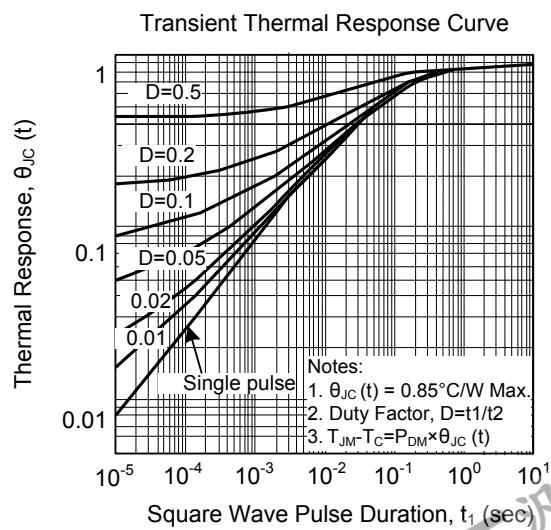
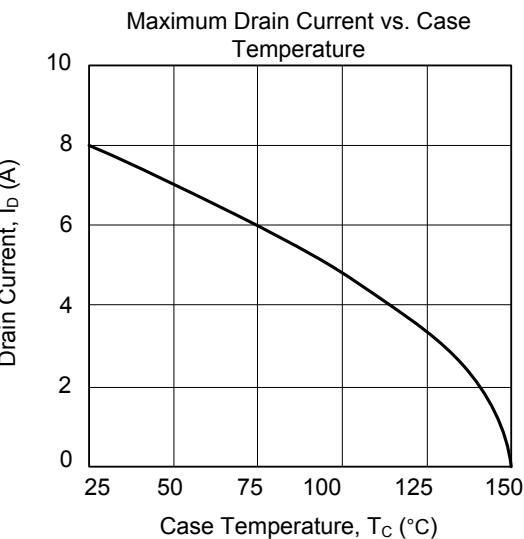
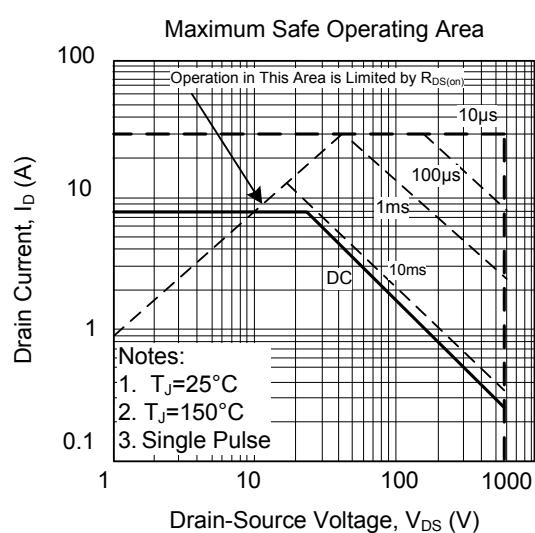
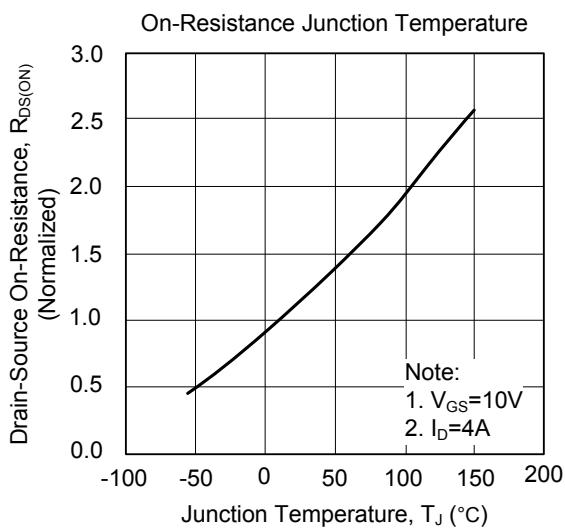
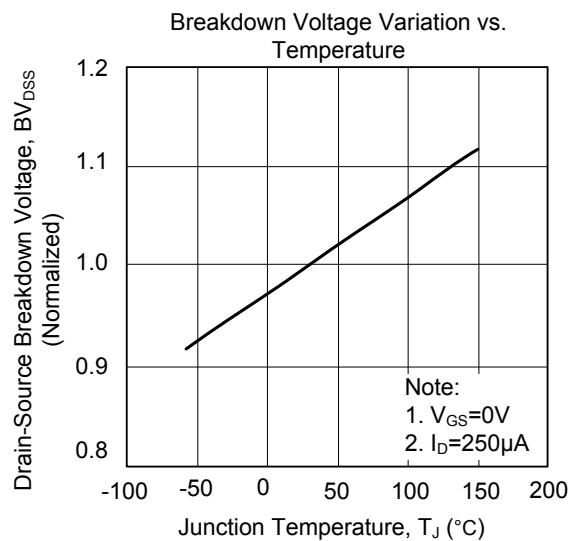
Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS(Cont.)



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.

